Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

1081.1091/JDH

SERIAL NO.
UNASSIGNED

APPLICANT

Katsuya IRIE, et al.

FILING DATE

June 13, 2000

GROUP

UNASSIGNED

(Use several sheets if necessary)

LIST OF REFERENCES CITED BY APPLICANT

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EXAMINER DAVID L LEWIS

DATE CONSIDERED

6/15/02

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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